

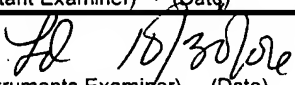


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/757,931	TRACHEWSKY ET AL.	
	Examiner	Art Unit	
	Nhan T. Le	2618	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
485		324		485	113	213			
INTERNATIONAL CLASSIFICATION				375	298				
H04B		1126							
Nhan T. Le (Nhan T. Le) (Assistant Examiner)				 EDWARD F. LONDON SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Patent Examiner)				Total Claims Allowed: 12	
 (Legal Instruments Examiner)				(Patent Examiner)				O.G. Print Claim(s): 1 O.G. Print Fig.: 3	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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